

Fail-Slow at Scale

Evidence of Hardware Performance Faults in Large Production Systems

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1st anecdote

~~fail-stop
fail-partial
fail-transient~~

**Slow
hardware!**

“...a **1Gb NIC card** on a machine that suddenly only transmits at **1 kbps**,

this slow machine caused a chain reaction upstream

*in such a way that the **100 node cluster** began to crawl at a snail's
pace.”*

**Cascading
impact!**

More anecdotes? **All** hardware?

- ❑ **Disk** throughput **dropped to 100 KB/s** due to vibration
- ❑ **SSDs** **stalled for seconds** due to firmware bugs
- ❑ **Memory cards** **degraded to 25% speed** due to a loose NVDIMM connection
- ❑ **CPUs** ran in **50% speed** due to lack of power

Fail-slow Hardware

- ❑ *Hardware that is still running and functional but in a degraded mode, significantly slower than its expected performance*

- ❑ In existing literature:
 - “fail-stutter” [Arpaci-Dusseau(s), HotOS '11]
 - “gray failure” [Huang et al. @ HotOS '17]
 - “limp mode” [Do et al. @ SoCC '13, Gunawi et al. @ SoCC '14, Kasick et al. @ FAST '10]
 - (But only **8 stories per paper** on avg. and mixed with SW issues)

Believe it?



Let's write a
paper
together

Yes, it's
real!



Evidences from ...

Institution	#Nodes
Company 1	>10,000
Company 2	150
Company 3	100
Company 4	>1,000
Company 5	>10,000

Institution	#Nodes
Univ. A	300
Univ. B	>100
Univ. C	>1,000
Univ. D	500
Nat'l Labs X	>1,000
Nat'l Labs Y	>10,000
Nat'l Labs Z	>10,000

Fail-slow
at
scale

Table 2: **Operational scale.**

Data and Methodology

□ 101 reports

- Unformatted text
- Written by engineers and operators (who still remember the incidents)
- 2000-2017 (mostly after 2010)
- Limitations and challenges:
 - No hardware-level performance logs [in formatted text]
 - No large-scale statistical analysis

□ Methodology

- An institution reports a *unique* set of root causes
 - “A corrupt buffer that slows down the networking card (causing packet loss and retransmission)”
 - Counted as 1 report from the institution (although might have happened many times)

Important Findings and Observations

§3.1 **Varying root causes:** Fail-slow hardware can be induced by internal causes such as firmware bugs or device errors/wear-outs as well as external factors such as configuration, environment, temperature, and power issues.

§3.2 **Faults convert from one form to another:** Fail-stop, -partial, and -transient faults can convert to fail-slow faults (*e.g.*, the overhead of frequent error masking of corrupt data can lead to performance degradation).

§3.3 **Varying symptoms:** Fail-slow behavior can exhibit a permanent slowdown, transient slowdown (up-and-down performance), partial slowdown (degradation of sub-components), and transient stop (*e.g.*, occasional reboots).

§3.4 **A long chain of root causes:** Fail-slow hardware can be induced by a long chain of causes (*e.g.*, a fan stopped working, making other fans run at maximal speeds, causing heavy vibration that degraded the disk performance).

§3.4 **Cascading impacts:** A fail-slow hardware can collapse the entire cluster performance; for example, a degraded NIC made many jobs lock task slots/containers in healthy machines, hence new jobs cannot find enough free slots.

§3.5 **Rare but deadly (long time to detect):** It can take hours to months to pinpoint and isolate a fail-slow hardware due to many reasons (*e.g.*, no full-stack visibility, environment conditions, cascading root causes and impacts).

Suggestions

§6.1 **To vendors:** When error masking becomes more frequent (*e.g.*, due to increasing internal faults), more explicit signals should be thrown, rather than running with a high overhead. Device-level performance statistics should be collected and reported (*e.g.*, via S.M.A.R.T) to facilitate further studies.

§6.2 **To operators:** 39% root causes are external factors, thus troubleshooting fail-slow hardware must be done online. Due to the cascading root causes and impacts, full-stack monitoring is needed. Fail-slow root causes and impacts exhibit some correlation, thus statistical correlation techniques may be useful (with full-stack monitoring).

§6.3 **To systems designers:** While software systems are effective in handling fail-stop (binary) model, more research is needed to tolerate fail-slow (non-binary) behavior. System architects, designers and developers can fault-inject their systems with all the root causes reported in this paper to evaluate the robustness of their systems.

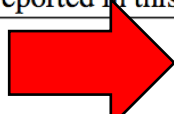


Table 1: **Summary of our findings and suggestions.**

Summary of findings

① Varying root causes

- Internal causes: firmware bugs, device errors
- External causes: temperature, power, environment, and configuration

② Faults convert

- Fail-stop, -partial, -transient → fail-slow

③ Varying symptoms

- Permanent, transient, and partial slowdown, and transient stop

④ Cascading nature

- Cascading root causes
- Cascading impacts

⑤ Rare but deadly

- Long time to detect (hours to months)

①

Varying root causes

		Hardware types					
Root		SSD	Disk	Mem	Net	CPU	Total
Internal root causes	Device errors	10	8	9	10	3	40
	Firmware bugs	6	3	0	9	2	20
External root causes	Temperature	1	3	0	2	5	11
	Power	1	0	1	0	6	8
	Environment	3	5	2	4	4	18
	Configuration	1	1	0	2	3	7
	Unknown	0	3	1	2	2	8

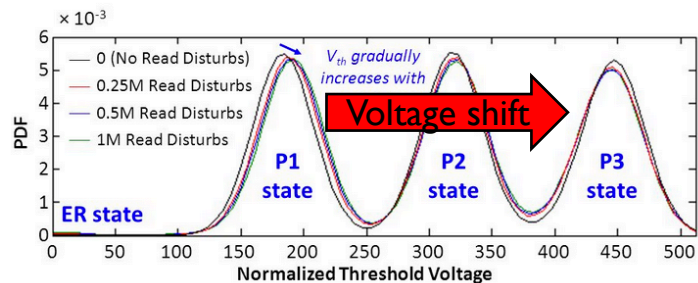
① Varying root causes

– Internal

– Device errors/wearouts

- Ex: SSD read disturb/retry + page reconstruction → longer latency and more load

Read Disturb Effect on V_{th} Distribution



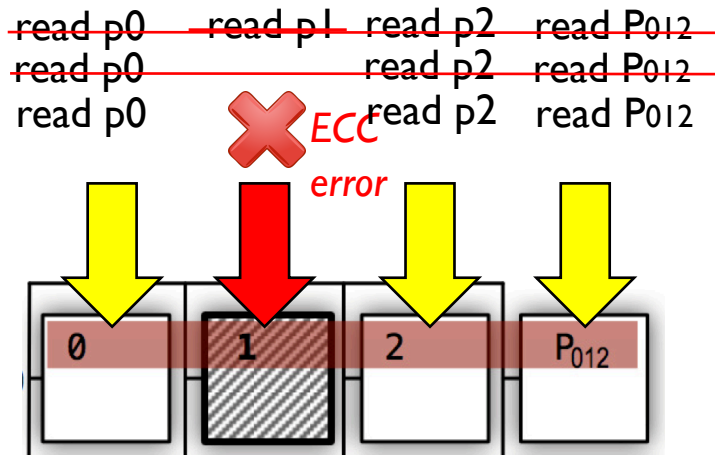
Picture from <http://slideplayer.com/slide/10095910/>

read(page X, $V_{th}=v1$) ✗
 read(page X, $V_{th}=v2$) ✗
 read(page X, $V_{th}=v3$) ✗
 read(page X, $V_{th}=v4$) ✓

4x slower!

read
retries!

$$1 = \text{XOR}(0, 2, P_{012})$$



RAIN: Redundant Array of Independent NAND

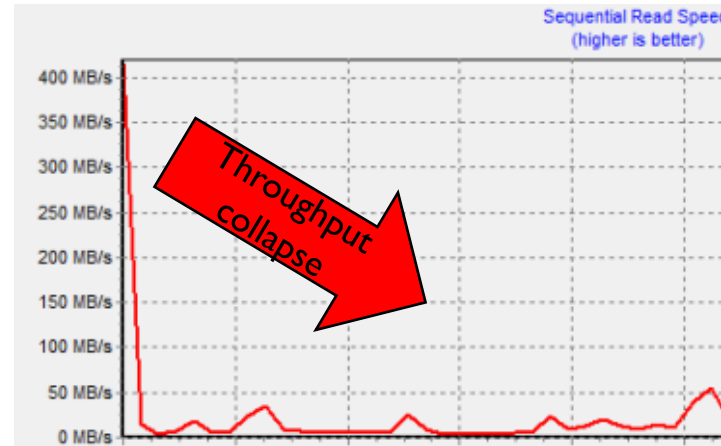
① Varying root causes

– Internal

- Device errors

- **Firmware bugs**

- [No details, proprietary component]
- SSD firmware bugs throttled **μs** to **ms** read performance
- Another example: 840 EVO firmware bugs [2014]



<https://www.anandtech.com/show/8550/samsung-acknowledges-the-ssd-840-evo-read-performance-bug-fix-is-on-the-way>

①

Varying root causes

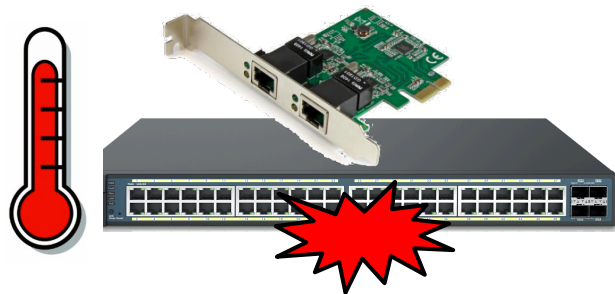
- Internal

Device errors and firmware bugs [More details in paper]

SSD	Disk	Memory	Network	Processors
Firmware bugs (us to ms read performance, internal metadata writes triggering assertion); Read retries with different voltages; RAIN/parity-based read reconstruction; Heavy GC in partially-failing SSD (not all chips are created equal); Broken parallelism by suboptimal wear-leveling; Hot temperature to wear-outs, repeated erases, and reduced space; Write amplification.	Firmware bugs (jitters, occasional timeouts, read retries, read-after-write mode); Device wearouts (disabling bad platters); Weak heads (gunk/dust accumulates between disk heads and platters); and other external factors such as temperature and vibration.	Address errors causing expensive ECC checks and repairs; Reduced space causing more cache hits; Loose NVDIMM connection; SRAM control-path errors causing recurrent reboots (transient stop).	Firmware bugs (buggy routing algorithm, multicast bad performance); NIC driver bugs; buggy switch-NIC auto-negotiation; Starving from electrons (bad design specification); bad VSCEL laser; Bitflips in device buffer; Loss packets cause TCP retries and collapse.	Buggy BIOS firmware down-clocking CPUs; Other external causes such as hot temperature and lack of power.

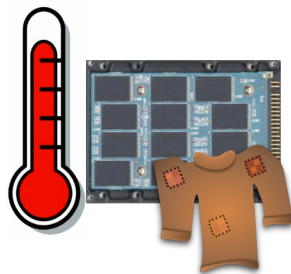
① Varying root causes

- Internal [Device errors, firmware bugs]
- External
 - **Temperature**



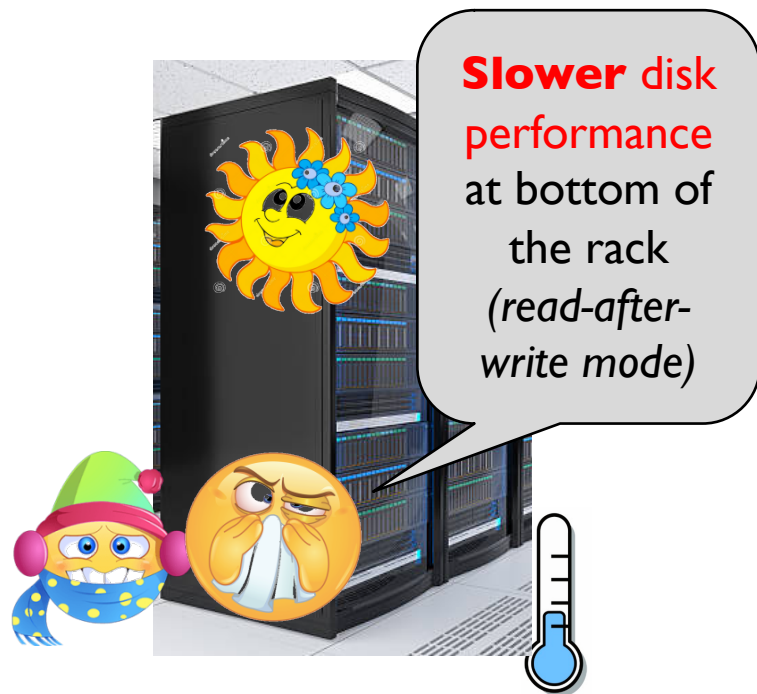
Hot temperature

- Corrupt packets
- Heavy TCP retransmission



Faster SSD

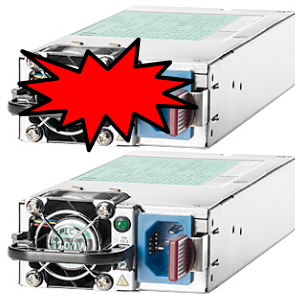
wearouts,
bad Vth →
more read retries



Cold-air-under-the-floor system

① Varying root causes

- Internal [Device errors, firmware bugs]
- External
 - Temperature
 - **Power**



4 machines, 2 power supplies
1 dead power → 50% CPU speed



Power-hungry applications →
throttling neighboring CPUs

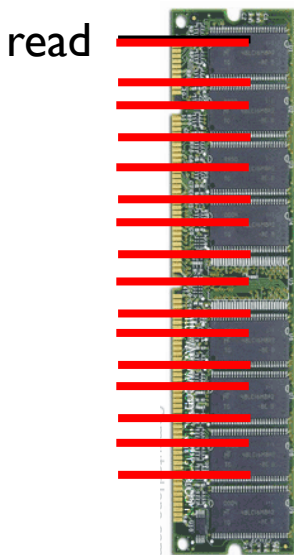
① Varying root causes

- Internal [Device errors, firmware bugs]
- **External**
 - Temperature
 - Power
 - **Environment**
 - Altitude, pinched cables, etc.
 - **Configuration**
 - A BIOS incorrectly downclocking CPUs of new machines
 - Initialization code disabled processor cache

① Varying root causes Device errors, firmware, temperature, power, environment, configuration

② Faults convert

- **Fail-transient → fail-slow**



Bit flips →
ECC repair
(*error masking*)

Okay if rare

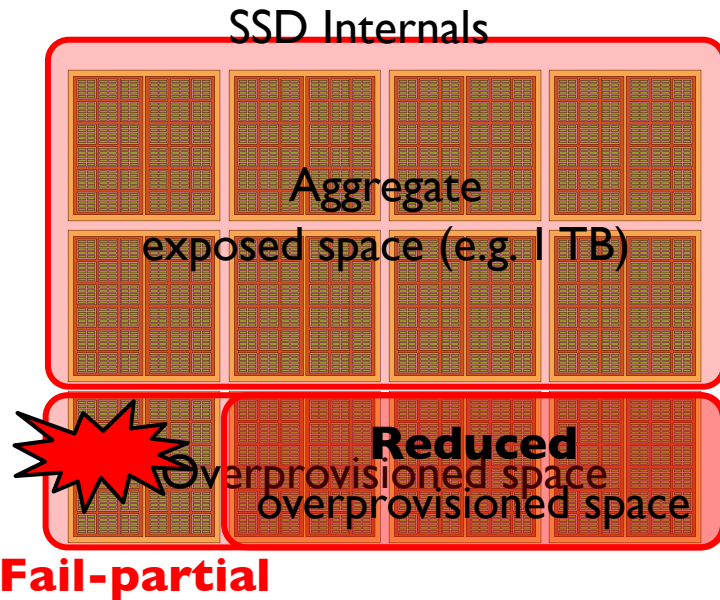
But, **frequent** errors
→ frequent error-masking/repair
→ repair latency becomes the *common* case

① Varying root causes Device errors, firmware, temperature, power, environment, configuration

② Faults convert

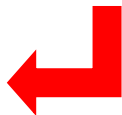
- Fail-transient → fail-slow
- **Fail-partial → fail-slow**

“Not all chips are created equal”
(some chips die faster)



→ Reduced overprovisioned space

→ *More frequent* GCs → **Slow** SSD

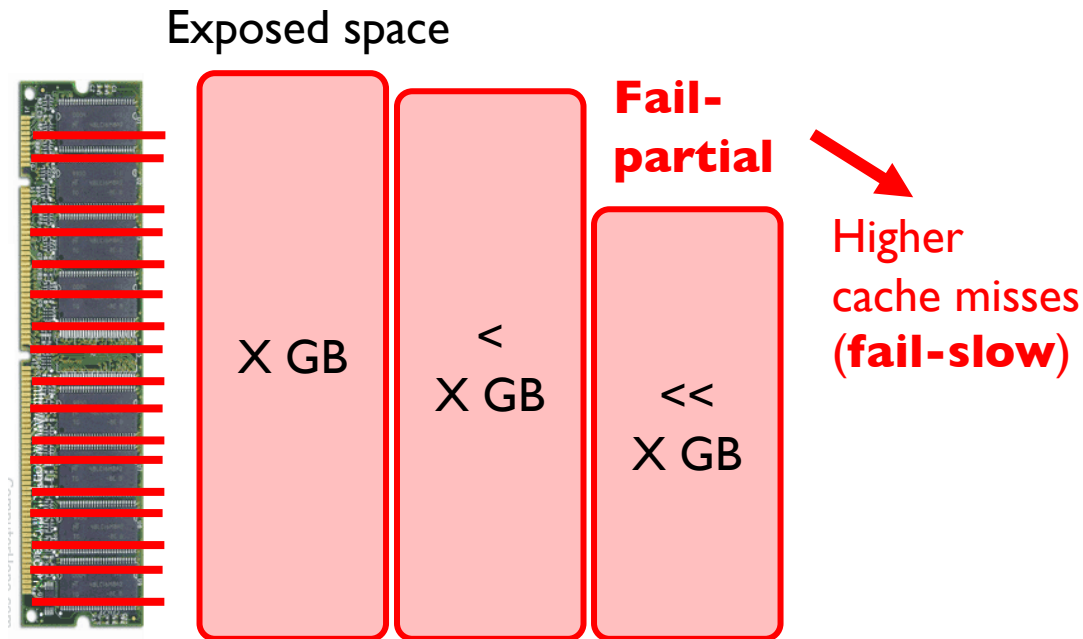


① Varying root causes Device errors, firmware, temperature, power, environment, configuration

② Faults convert

- Fail-transient $\rightarrow$ fail-slow
- **Fail-partial $\rightarrow$ fail-slow**

Custom memory chips that mask (hide) bad addresses

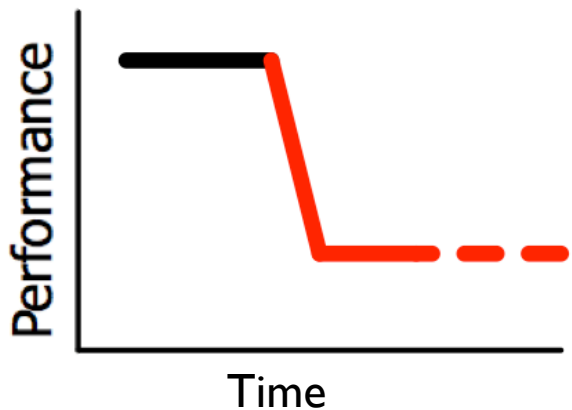


① Varying root causes Device errors, firmware, temperature, power, environment, configuration

② Faults convert Fail-stop, -transient, -partial → fail-slow

③ **Varying symptoms**

– **Permanent slowdown**

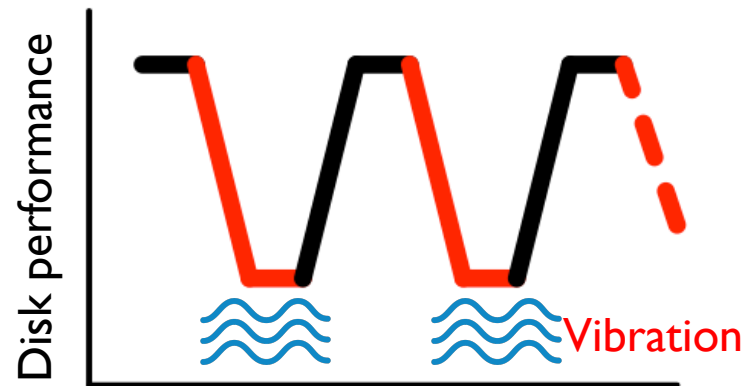
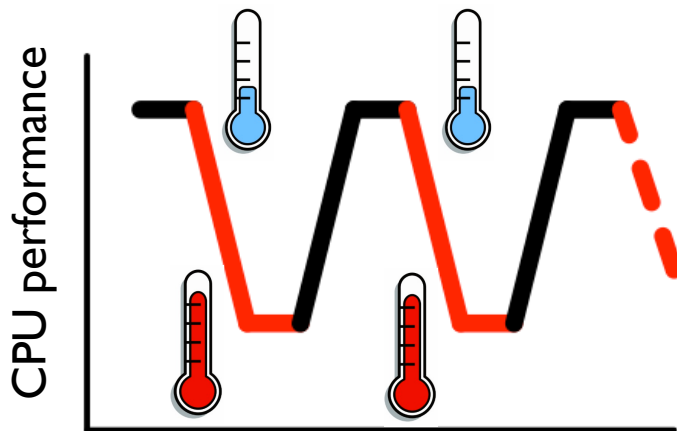


① Varying root causes Device errors, firmware, temperature, power, environment, configuration

② Faults convert Fail-stop, -transient, -partial → fail-slow

③ Varying symptoms

- Permanent slowdown 
- **Transient slowdown**

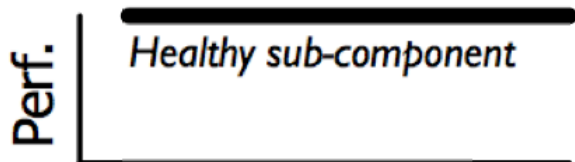


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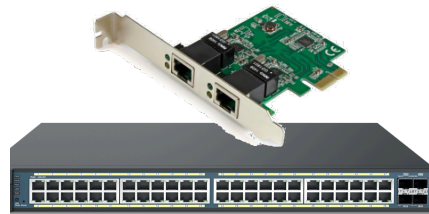
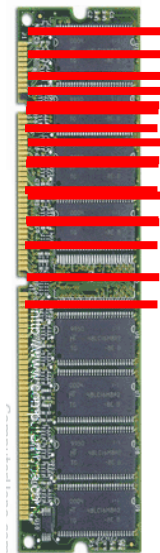
③ Varying symptoms

- Permanent slowdown 
- Transient slowdown 
- **Partial slowdown**



Slow
reads
(ECC
repairs)

Fast
reads



Small packets (fast)

> 1500-byte packets
(very slow)

[Buggy firmware/config
related to jumbo frames]

① Varying root causes Device errors, firmware, temperature, power, environment, configuration

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③ Varying symptoms

- Permanent slowdown
- Transient slowdown
- Partial slowdown
- **Transient stop**



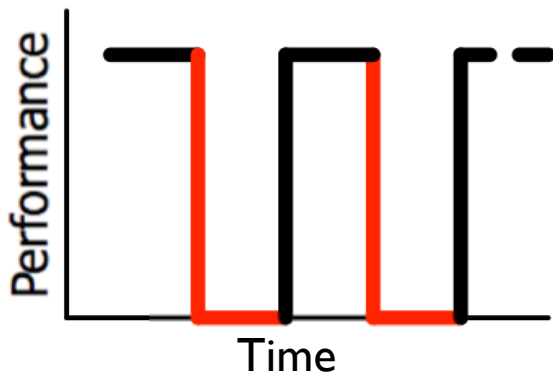
A bad batch of SSDs
“*disappeared*” and
then reappeared

*A firmware bug
triggered hardware
assertion failure*



Host Bus Adapter
recurrent resets

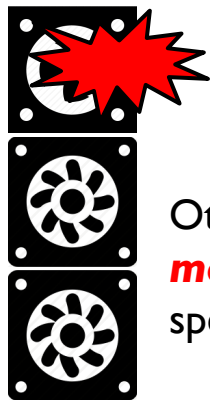
*Uncorrectable bit flips
in SRAM control paths*



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- ② Faults convert Fail-stop, -transient, -partial → fail-slow
- ③ Varying symptoms Permanent, transient, partial slowdown and transient stop
- ④ **Cascading nature**
 - Cascading **root causes**



Fans
normal
speed

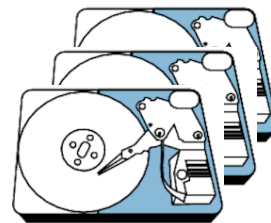


One died

Other fans
maximum
speed



Noise and
vibration

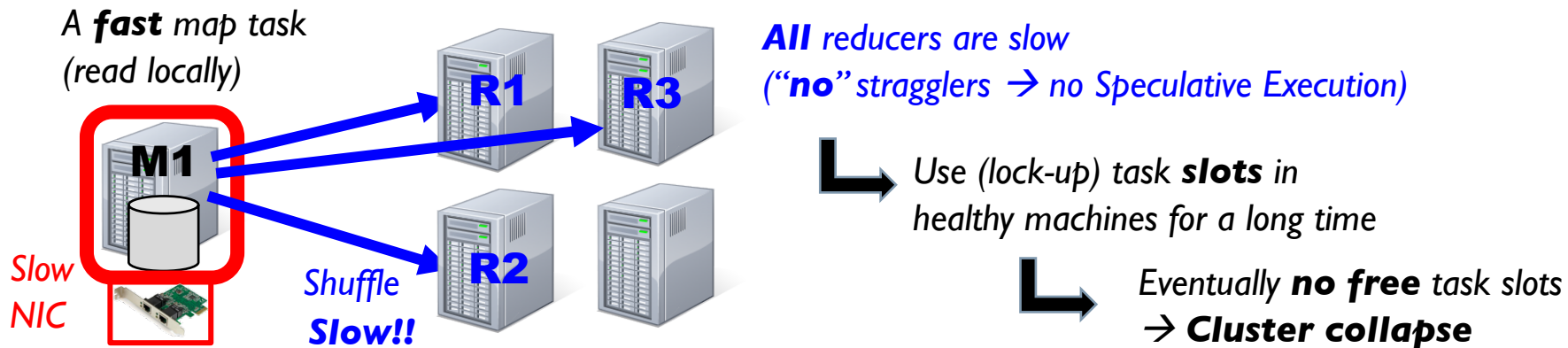


Disk
throughput
collapses to
KB/s

Bad disks?
No!



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 - Cascading root causes
 - **Cascading impacts** e.g. in Hadoop MapReduce



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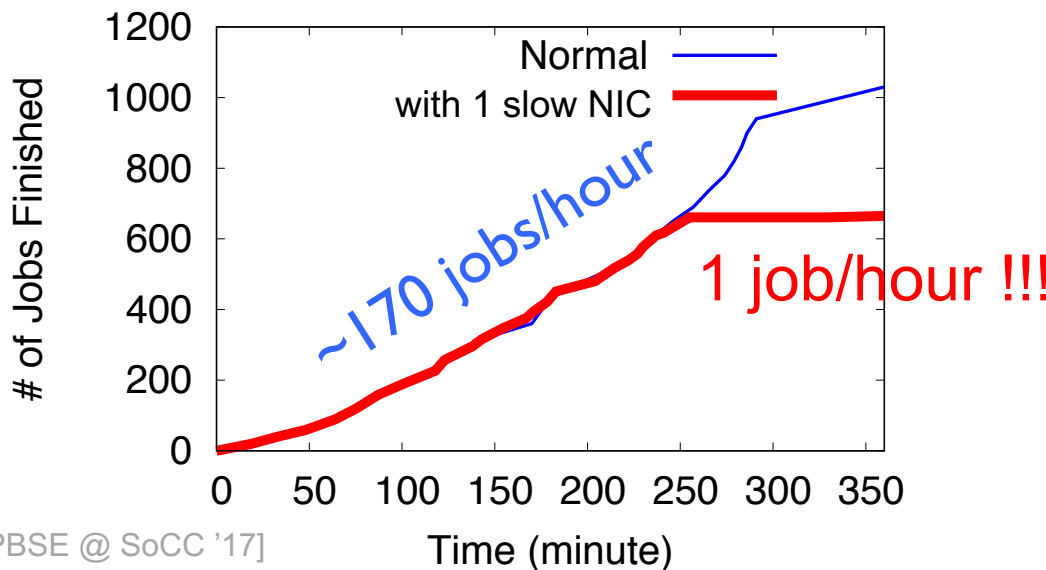
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- Cascading root causes
- Cascading **impacts**

Facebook Hadoop Jobs, 30 nodes



[From PBSE @ SoCC '17]

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⑤ **Rare but deadly**

- 13% detected in **hours**
- 13% in **days**
- 11% in **weeks**
- 17% in **months**
- (50% unknown)

Why?

- External causes and cascading nature
(*vibration → slow disk*); *offline testing passes*
- No full-stack monitoring/correlation
hot temperature → slow CPUs → slow Hadoop
→ debug Hadoop logs?
- Rare? Ignore?

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Suggestions to vendors,
operators, and systems designers

Suggestions

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§6.3 **To systems designers:** While software systems are effective in handling fail-stop (binary) model, more research is needed to tolerate fail-slow (non-binary) behavior. System architects, designers and developers can fault-inject their systems with all the root causes reported in this paper to evaluate the robustness of their systems.

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Conclusion:

Modern, advanced systems
+ Fail-slow hardware



Thank
you!
Questions?

EXTRA

Suggestions

❑ **To vendors:**

- Make the implicits explicit
 - Frequent error masking → hard errors
- Record/expose device-level performance statistics

❑ **To operators:**

- Online diagnosis
 - (39% root causes are external)
- Full-stack monitoring
- Full-stack statistical correlation

❑ **To systems designers:**

- Make the implicits explicit
 - Jobs retried “infinite” time
- Convert fail-slow to fail-stop? (challenging)
- Fail-slow fault injections

	Symptoms			
HW Type	Perm.	Trans.	Partial	Tr. Stop
SSD	6	7	3	3
Disk	9	4	3	5
Mem	7	1	0	4
Net	21	0	5	2
CPU	10	6	1	3

Table 4: **Fail-slow symptoms across hardware types.**

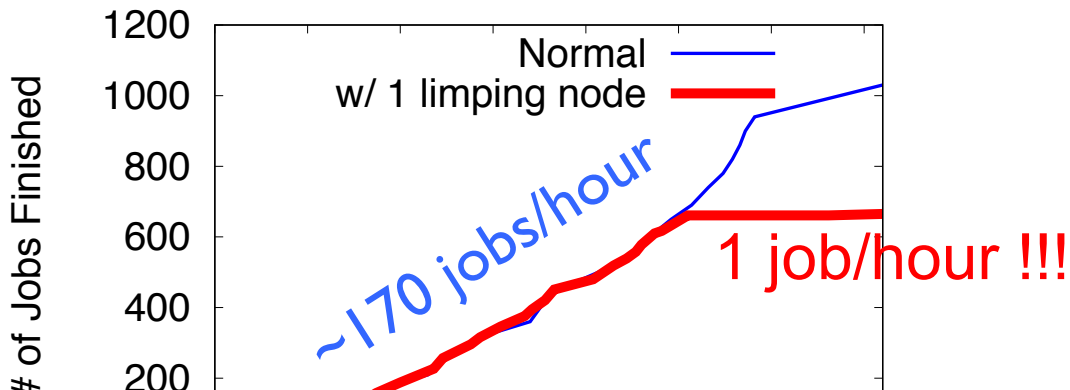
	Symptoms			
Root	Perm.	Trans.	Partial	Tr. Stop
ERR	19	8	7	6
FW	11	3	1	4
TEMP	6	2	1	2
PWR	3	2	1	2
ENV	11	3	3	1
CONF	6	1	0	0
UNK	5	1	0	2

Table 5: **Fail-slow symptoms across root causes.**

Operators

- ❑ Cannot use application bandwidth check (all are affected)

Facebook Hadoop Jobs, 30 nodes



Hadoop, not fully tail/limpware tolerant??



① Varying root causes Device errors, firmware, temperature, power, environment, configuration

② Faults convert

- **Fail-stop → fail-slow**
 - Fail-stop power → fail-slow CPUs
 - Fail-stop disk → fail-slow RAID

